Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/629,835	FURUMIYA ET AL.
Examiner	Art Unit
Kim-Kwok CHU	2653

	SEAR	CHED	
Class	Subclass	Date	Examiner
369	59.12	3/17/2006	кс
369	59.11	3/17/2006	кс
369	59.23	3/17/2006	кс
369	44.37	3/17/2006	кс
369	53.31	3/17/2006	кс
369	47.52	3/17/2006	LKC
369	47.53	3/17/2006	кс
369	116	3/17/2006	кс

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

DATE 3/17/2006	KC
3/17/2006	кс